

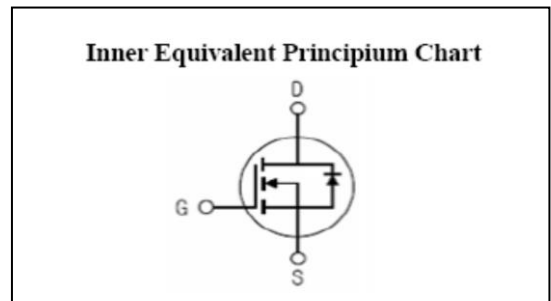
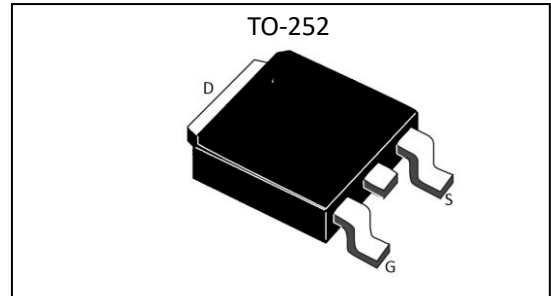
Features:

- Fast Switching
- Low ON Resistance ($R_{dson} \leq 55\Omega$)
- Low Gate Charge
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

Applications:

- Power switch circuit of adaptor and charger

V_{DSS}	1000	V
I_D	0.5	A
$P_D(T_C=25^\circ C)$	25	W
$R_{DS(ON).TYPE}$	40	Ω



Absolute ($T_c=25^\circ C$ unless otherwise specified):

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	1000	V
I_D	Continuous Drain Current	0.5	A
	Continuous Drain Current $T_C=100^\circ C$	0.17	A
I_{DM}^{a1}	Pulsed Drain Current	1.5	A
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}^{a2}	Single Pulse Avalanche Energy	12	mJ
E_{AR}^{a1}	Avalanche Energy ,Repetitive	4	mJ
I_{AR}^{a1}	Avalanche Current	0.3	A
dv/dt^{a3}	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	25	W
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ C$
T_L	Maximum Temperature for Soldering	300	$^\circ C$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

Thermal Characteristics

Symbol	Parameter	Rating	Units
R _{θJC}	Thermal Resistance, Junction-to-Case	5.0	°C/ W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	100	°C/ W

Electrical Characteristics (T_c= 25°C unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	1000	--	--	V
ΔBV _{DSS} /ΔT _J	Bvdss Temperature Coefficient	I _D =250uA, Reference 25°C	--	0.51	--	V/°C
I _{DSS}	Drain to Source Leakage Current	V _{DS} = 1000V, V _{GS} =0V, T _a =25°C	--	--	1	μA
		V _{DS} = 800V, V _{GS} =0V, T _a = 125°C	--	--	100	
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} = +30V	--	--	100	nA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} = -30V	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} = 10V, I _D =0.25A	--	--	55	Ω
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2.0	--	4.0	V
g _{fs}	Forward Trans conductance	V _{DS} = 15V, I _D =0.25A	--	0.42	--	S
Pulse width < 380μs; duty cycle < 2%.						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C _{iss}	Input Capacitance	V _{GS} =0V V _{DS} =25V f=1.0MHz	--	70	--	pF
C _{oss}	Output Capacitance		--	14.5	--	
C _{rss}	Reverse Transfer Capacitance		--	2.8	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D =0.5A, V _{DD} =500V V _{GS} = 10V, R _g =4.7Ω	--	19	--	ns
t _r	Rise Time		--	11.5	--	
t _{d(OFF)}	Turn-Off Delay Time		--	48	--	
t _f	Fall Time		--	16.5	--	
Q _g	Total Gate Charge	I _D =0.5A, V _{DD} =500V V _{GS} = 10V	--	10.0	--	nC
Q _{gs}	Gate to Source Charge		--	0.7	--	
Q _{gd}	Gate to Drain ("Miller") Charge		--	7.2	--	

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_{SD}	Continuous Source Current (Body Diode)		--	--	0.5	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	1.5	A
V_{SD}	Diode Forward Voltage	$I_S=0.5A, V_{GS}=0V$	--	--	1.5	V
t_{rr}	Reverse Recovery Time	$I_S=0.5A, T_j=25^\circ C$	--	374	--	ns
Q_{rr}	Reverse Recovery Charge	$di_F/dt=100A/\mu s, V_{GS}=0V$	--	735	--	μC

a1: Repetitive rating; pulse width limited by maximum junction temperature

a2: $L=10mH, I_D=1.5A$, Start $T_j=25^\circ C$

a3: $I_{SD}=0.5A, di/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS}$, Start $T_j=25^\circ C$

Characteristics Curve:

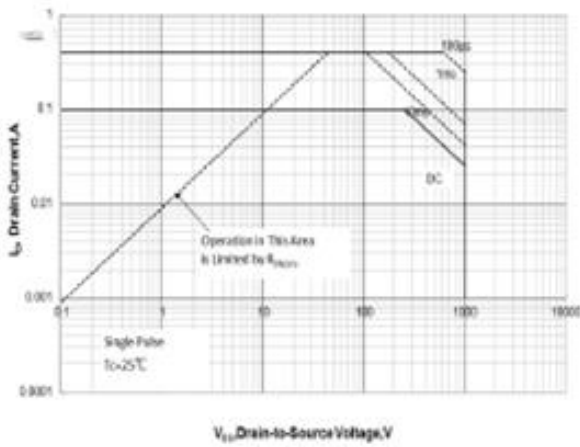


Figure 1 Maximum Forward Bias Safe Operating Area

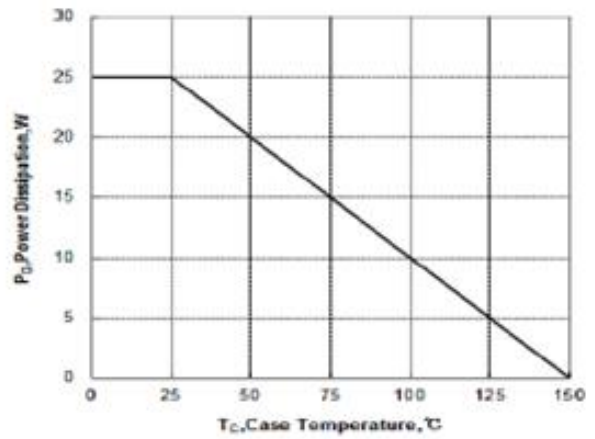


Figure 2 Maximum Power dissipation vs Case Temperature

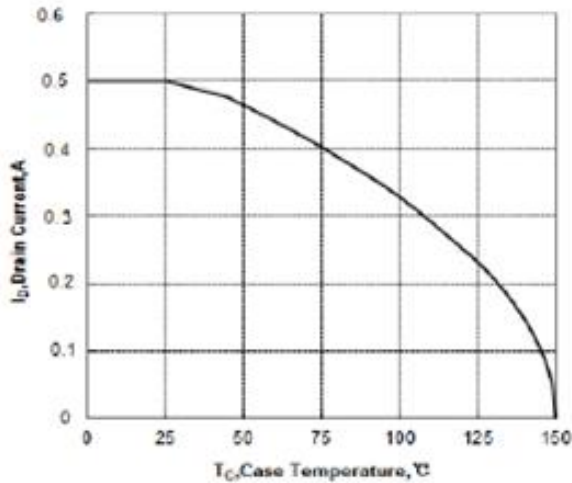


Figure 3 Maximum Continuous Drain Current vs Case Temperature

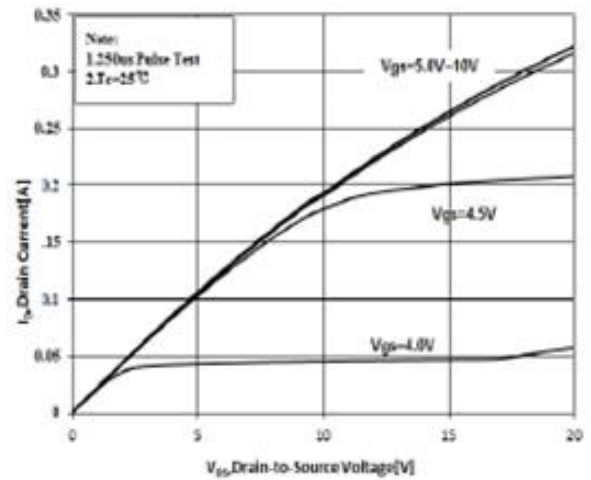


Figure 4 Typical Output Characteristics

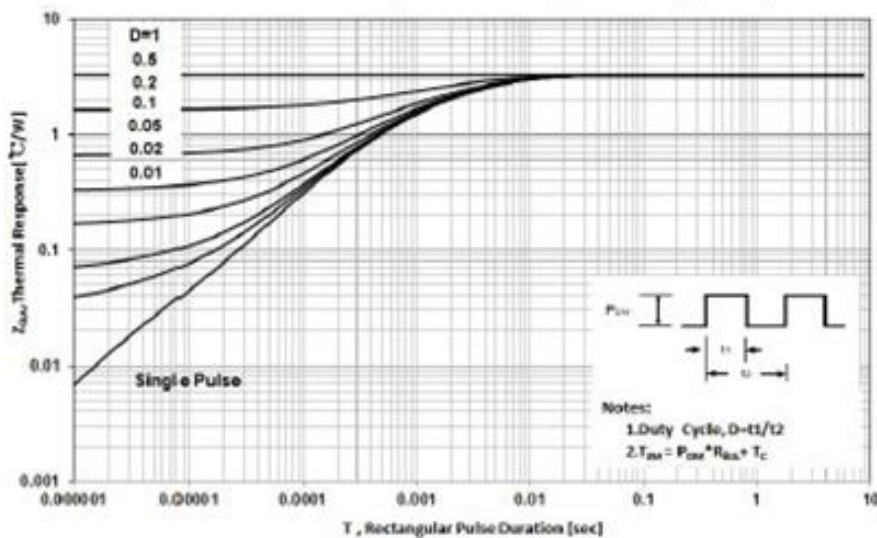


Figure 5 Maximum Effective Thermal Impedance , Junction to Case

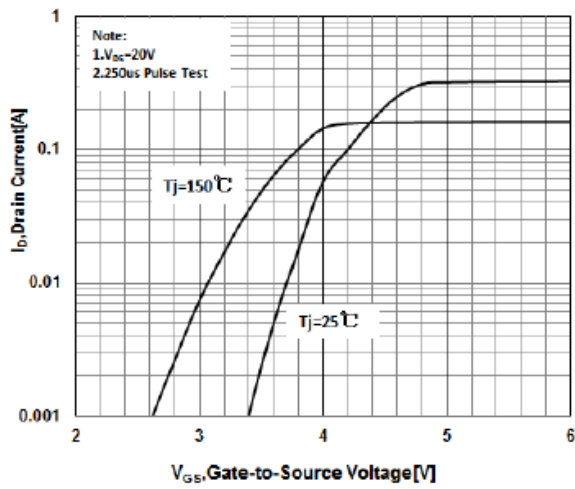


Figure 6 Typical Transfer Characteristics

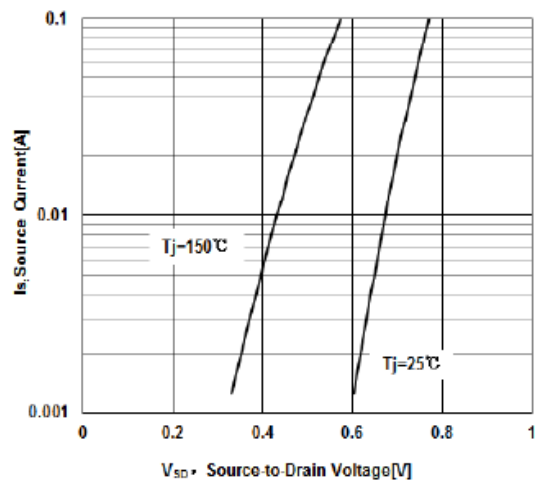


Figure 7 Typical Body Diode Transfer Characteristics

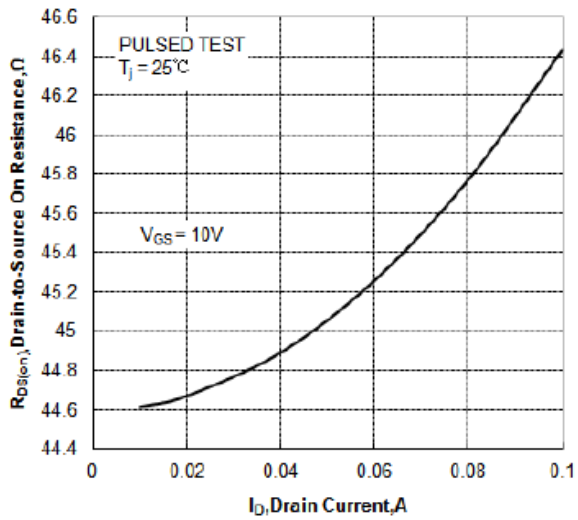


Figure 8 Typical Drain to Source ON Resistance vs Drain Current

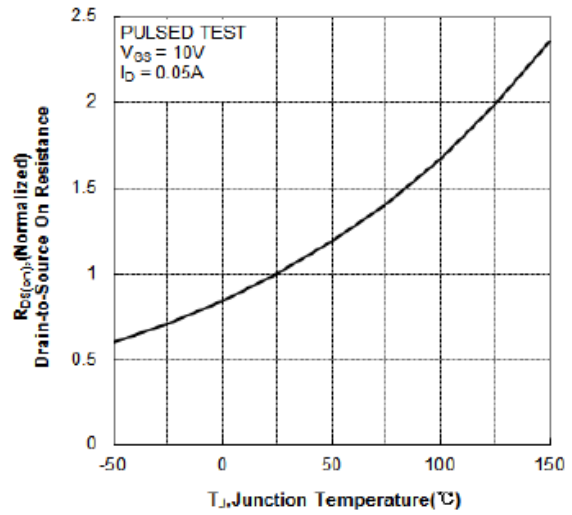


Figure 9 Typical Drain to Source on Resistance vs Junction Temperature